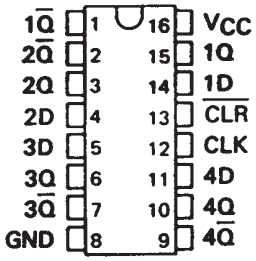
- **Contains Four Flip-Flops with Double Rail Outputs**
- **Buffered Clock and Clear Inputs**
- **Individual Data Inputs to Each Flip-Flop**

description

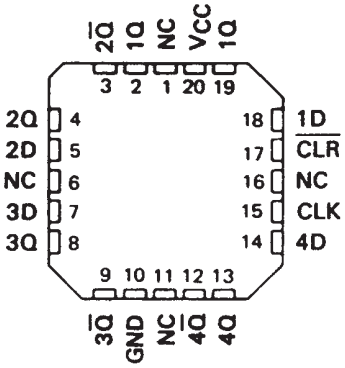
These monolithic, positive-edge triggered flip-flops utilize the latest low-power Schottky circuitry to implement D-type flip-flop logic. They have a direct clear input and complementary outputs from each flip-flop.

Information at the D inputs meeting the setup time requirements is transferred to the Q outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a particular voltage level and is not directly related to the transition time of the positive going pulse. When the clock input is at either the high or low level, the D input signal has no effect at the output.

SN54LS171 . . . J OR W PACKAGE
SN74LS171 . . . D OR N PACKAGE
(TOP VIEW)

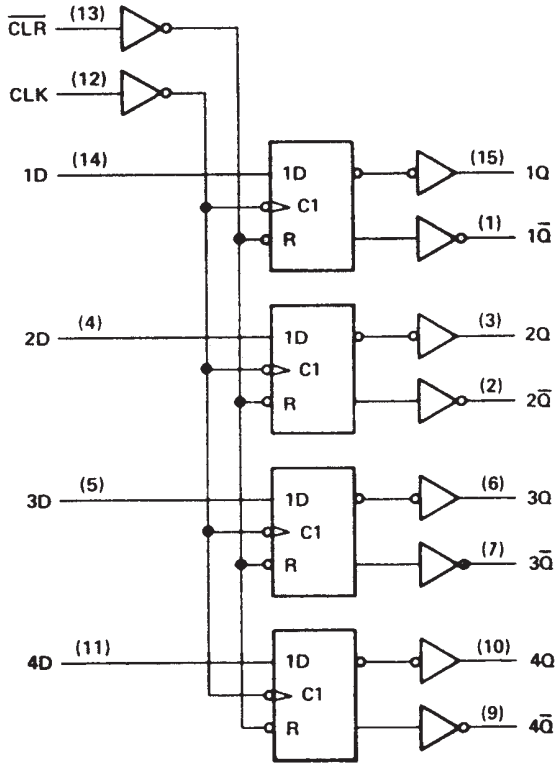


SN54LS171 . . . FK PACKAGE
(TOP VIEW)



NC-No internal connection

logic diagram (positive logic)

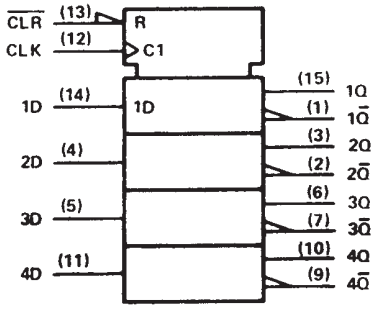


Pin numbers shown are for D, J, N, and W packages.

FUNCTION TABLE
(EACH FLIP-FLOP)

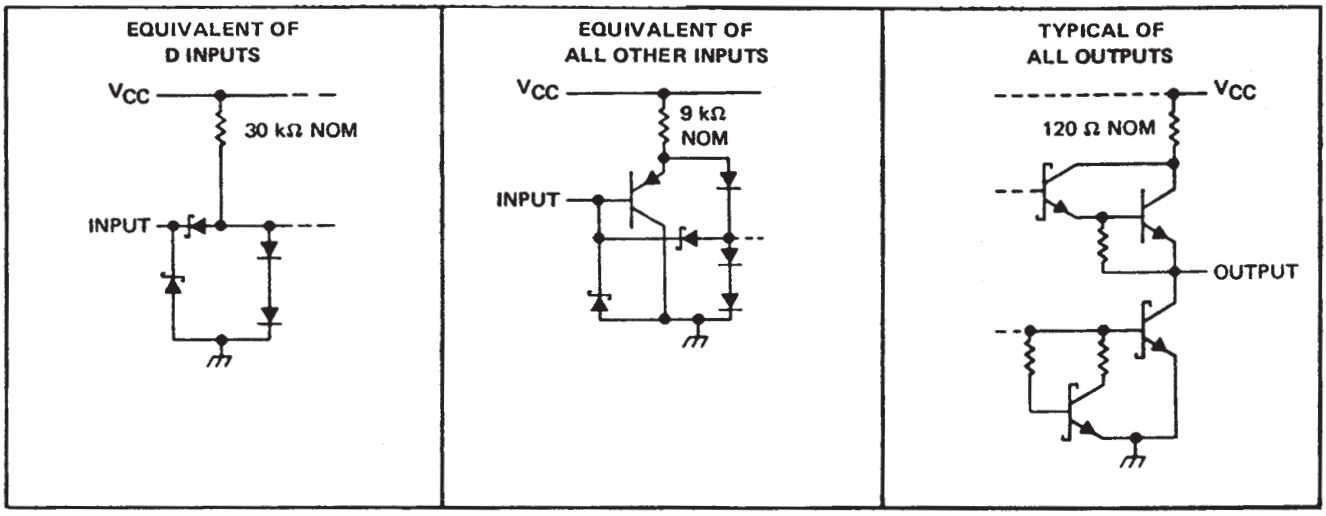
INPUTS			OUTPUTS	
$\overline{CLR}$	CLK	D	Q	$\overline{Q}$
L	X	X	L	H
H	↑	H	H	L
H	↑	L	L	H
H	L	X	Q_0	$\overline{Q}_0$

logic symbol†



†This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

schematics of inputs and outputs



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (See Note 1) . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54LS171 Circuits . . . . . −55°C to 125°C
SN74LS171 Circuits . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

			SN54LS171			SN74LS171			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage		4.5	5	5.5	4.75	5	5.25	V
V_{IH}	High-level input voltage		2			2			V
V_{IL}	Low-level input voltage				0.7			0.8	V
I_{OH}	High-level output current				−0.4			−0.4	mA
I_{OL}	Low-level output current				4			8	mA
f_{clock}	Clock frequency		0		20	0		20	MHz
t_w	Width of clock or clear pulse		20			20			ns
t_{su}	Setup time	Data input	20			20			ns
		Clear inactive-state	25			25			
t_h	Data hold time		5			5			ns
T_A	Operating free-air temperature		−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			TEST CONDITIONS†			SN54LS171			SN74LS171			UNIT
						MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	Input clamp voltage		V_{CC} = MIN,	I_I = – 18 mA				– 1.5			– 1.5	V
V_{OH}	High-level output voltage		V_{CC} = MIN, V_{IL} = MAX	V_{IH} = 2 V,	I_{OH} = – 1 mA	2.5	3.4		2.7	3.4		V
V_{OL}	Low-level output voltage		V_{CC} = MIN, V_{IL} = MAX	V_{IH} = 2 V,	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
					I_{OL} = 8 mA					0.35	0.5	V
I_I	Input current at maximum input voltage		V_{CC} = MAX,	V_I = 7 V				0.1			0.1	mA
I_{IH}	High-level input current		V_{CC} = MAX,	V_I = 2.7 V				20			20	μA
I_{IL}	Low-level input current	D inputs	V_{CC} = MAX,	V_I = 0.4 V				– 0.4			– 0.4	mA
		All others						– 0.2			– 0.2	mA
I_{OS}§	Short-circuit output current		V_{CC} = MAX,	V_O = 0 V		– 20		– 100	– 20		– 100	mA
I_{CC}	Supply current		V_{CC} = MAX,	See Note 1			14	25		14	25	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.
§ Not more than one output should be shorted at a time and the duration of the short-circuit should not exceed one second.
NOTE 1: I_{CC} is measured with all inputs grounded and all outputs open.

switching characteristics, V_{CC} = 5 V, T_A = 25°C (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	'LS171			UNIT
				MIN	TYP	MAX	
f_{max}			R_L = 2 kΩ, C_L = 15 pF	20	30		MHz
t_{PLH}	CLK	Q, $\overline{Q}$			15	25	ns
t_{PHL}					18	30	ns
t_{PLH}	$\overline{CLR}$	Q			18	30	ns
t_{PHL}					24	40	ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

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